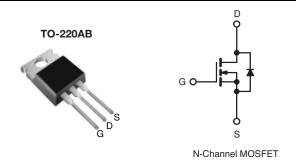


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	500			
R _{DS(on)} (Ω)	V _{GS} = 10 V 0.85			
Q _g (Max.) (nC)	39			
Q _{gs} (nC)	10			
Q _{gd} (nC)	19			
Configuration	Single			



FEATURES

- Ultra Low Gate Charge
- Reduced Gate Drive Requirement
- Enhanced 30 V V_{GS} Rating
- Reduced C_{iss}, C_{oss}, C_{rss}
- Extremely High Frequency Operation
- Repetitive Avalanche Rated
- Compliant to RoHS Directive 2002/95/EC



This new series of low charge Power MOSFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing the new LCDMOS technology, the device improvements are achieved without added product cost, allowing for reduced gate drive requirements and total system savings. In addition, reduced switching losses and improved efficiency are achievable in a variety of high frequency applications. Frequencies of a few MHz at high current are possible using the new low charge MOSFETs.

These device improvements combined with the proven ruggedness and reliability that are characteristic of Power MOSFETs offer the designer a new standard in power transistors for switching applications.

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRF840LCPbF		
Lead (FD)-life	SiHF840LC-E3		
SnPb	IRF840LC		
SIFD	SiHF840LC		

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)					
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage	V_{DS}	500	V		
Gate-Source Voltage	V_{GS}	± 30	- V		
Continuous Drain Current	$T_C = 25 ^{\circ}C$	I _D	8.0	А	
Continuous Drain Current	V_{GS} at 10 V $T_{C} = 100 ^{\circ}\text{C}$		5.1		
Pulsed Drain Current ^a	I _{DM}	28			
Linear Derating Factor		1.0	W/°C		
Single Pulse Avalanche Energy ^b	E _{AS}	510	mJ		
Repetitive Avalanche Current ^a	I _{AR}	8.0	Α		
Repetitive Avalanche Energy ^a	E _{AR}	13	mJ		
Maximum Power Dissipation $T_C = 25 ^{\circ}C$		P_{D}	125	W	
Peak Diode Recovery dV/dtc	dV/dt	3.5	V/ns		
Operating Junction and Storage Temperature Rang	T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)		300 ^d	7		
Mounting Toyour	6 20 or M2 corour		10	lbf ⋅ in	
Mounting Torque	6-32 or M3 screw		1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 14 mH, R_g = 25 Ω , I_{AS} = 8.0 A (see fig. 12).
- c. $I_{SD} \le 8.0$ A, $dI/dt \le 100$ A/ μ s, $V_{DD} \le V_{DS}$, $T_{J} \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRF840LC, SiHF840LC

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THERMAL RESISTANCE					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.63	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} :	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V	ı	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		= 500 V, V _{GS} = 0 V /, V _{GS} = 0 V, T _J = 125 °C	-	-	25 250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 4.8 A ^b	-	-	0.85	Ω
Forward Transconductance	9 _{fs}	V _{DS}	= 50 V, I _D = 4.8 A ^b	4.0	-	-	S
Dynamic							
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	1100	-	
Output Capacitance	C _{oss}	1	$V_{DS} = 25 \text{ V},$	-	170	-	pF
Reverse Transfer Capacitance	C_{rss}] f = 1	.0 MHz, see fig. 5	-	18	-	
Total Gate Charge	Qg			-	-	39	nC
Gate-Source Charge	Q_{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 8.0 \text{ A}, V_{DS} = 400 \text{ V}$ see fig. 6 and 13 ^b		-	10	
Gate-Drain Charge	Q_{gd}		and high a minum to	i	-	19	
Turn-On Delay Time	t _{d(on)}			ı	12	-	
Rise Time	t _r		$V_{DD} = 250 \text{ V}, I_D = 8.0 \text{ A},$		25	-	ns
Turn-Off Delay Time	$t_{d(off)}$	R_g = 9.1 Ω, R_D = 30 Ω see fig. 10 ^b		ı	27	-	
Fall Time	t _f		. See lig. 10		19	-	
Internal Drain Inductance	L_{D}	6 mm (0.25")	Between lead, 6 mm (0.25") from		4.5	-	- N.I.
Internal Source Inductance	L _S	package and center of die contact		-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	8.0	^
Pulsed Diode Forward Current ^a	I _{SM}			-	-	28	- A
Body Diode Voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 8.0 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	2.0	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 8.0 A, dl/dt = 100 A/μs ^b		-	490	740	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	3.0	4.5	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

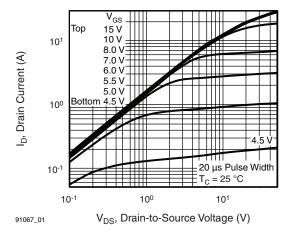


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

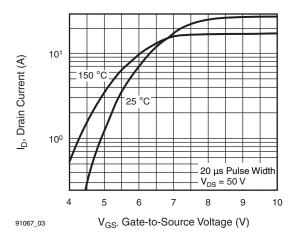


Fig. 3 - Typical Transfer Characteristics

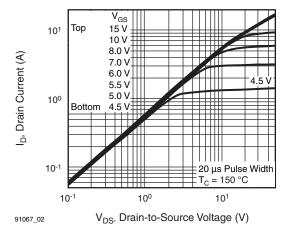


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

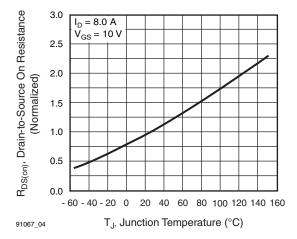
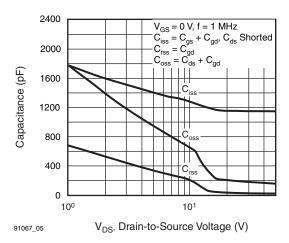


Fig. 4 - Normalized On-Resistance vs. Temperature

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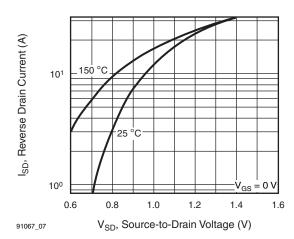
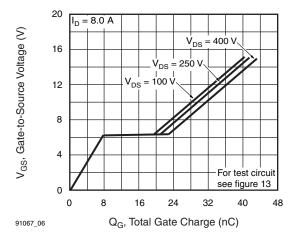


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

Fig. 7 - Typical Source-Drain Diode Forward Voltage



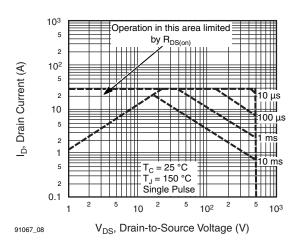


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

Fig. 8 - Maximum Safe Operating Area



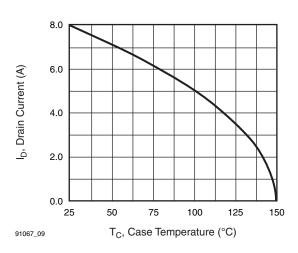


Fig. 9 - Maximum Drain Current vs. Case Temperature

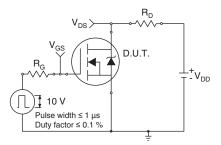


Fig. 10a - Switching Time Test Circuit

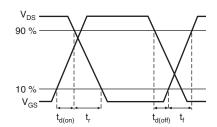


Fig. 10b - Switching Time Waveforms

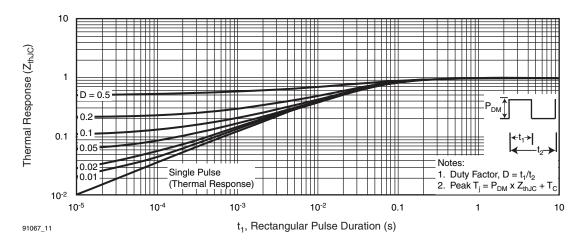


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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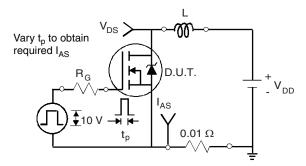


Fig. 12a - Unclamped Inductive Test Circuit

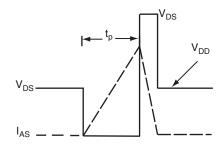


Fig. 12b - Unclamped Inductive Waveforms

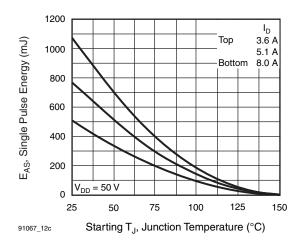


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

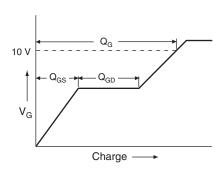


Fig. 13a - Basic Gate Charge Waveform

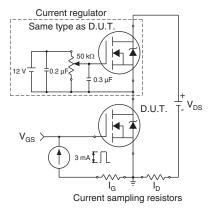
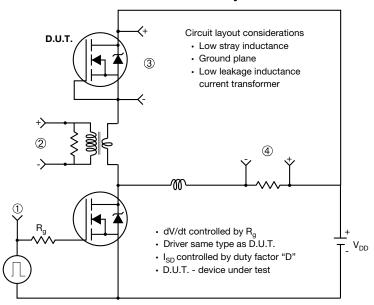


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



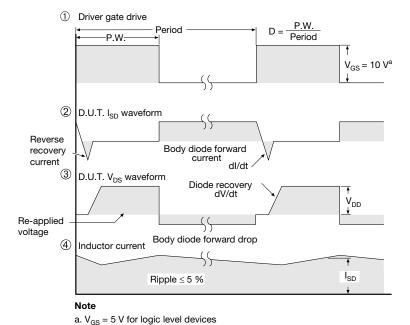


Fig. 14 - For N-Channel

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TO-220-1



DIM	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.24	4.65	0.167	0.183	
b	0.69	1.02	0.027	0.040	
b(1)	1.14	1.78	0.045	0.070	
С	0.36	0.61	0.014	0.024	
D	14.33	15.85	0.564	0.624	
E	9.96	10.52	0.392	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.10	6.71	0.240	0.264	
J(1)	2.41	2.92	0.095	0.115	
L	13.36	14.40	0.526	0.567	
L(1)	3.33	4.04	0.131	0.159	
ØР	3.53	3.94	0.139	0.155	
Q	2.54	3.00	0.100	0.118	
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031					

Note

 \bullet $M^{\star}=0.052$ inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



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